



June 1997

## 35A, 1200V, UFS Series N-Channel IGBTs

### Features

- 35A, 1200V,  $T_C = 25^\circ\text{C}$
- 1200V Switching SOA Capability
- Typical Fall Time ..... 350ns at  $T_J = 150^\circ\text{C}$
- Short Circuit Rating
- Low Conduction Loss

### Ordering Information

PART NUMBER	PACKAGE	BRAND
HGTG15N120C3	TO-247	15N120C3
HGTP15N120C3	TO-220AB	15N120C3
HGT1S15N120C3	TO-262AA	15N120C3
HGT1S15N120C3S	TO-263AB	15N120C3

NOTE: When ordering, use the entire part number. Add the suffix 9A to obtain the TO-263 variant in tape and reel; i.e., HGT1S15N120C3S9A.

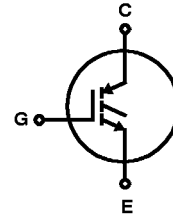
Formerly Developmental Type TA49145.

### Description

The HGTG15N120C3, HGTP15N120C3, HGT1S15N120C3 and HGT1S15N120C3S are MOS gated high voltage switching devices combining the best features of MOSFETs and bipolar transistors. These devices have the high input impedance of a MOSFET and the low on-state conduction loss of a bipolar transistor. The much lower on-state voltage drop varies only moderately between  $25^\circ\text{C}$  and  $150^\circ\text{C}$ .

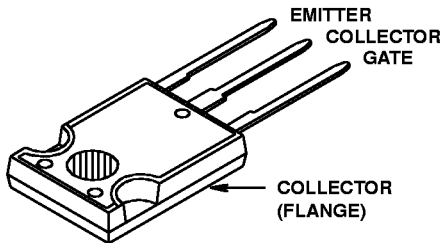
The IGBT is ideal for many high voltage switching applications operating at moderate frequencies where low conduction losses are essential, such as: AC and DC motor controls, power supplies and drivers for solenoids, relays and contactors.

### Symbol

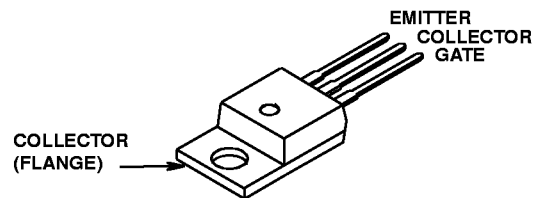


### Packaging

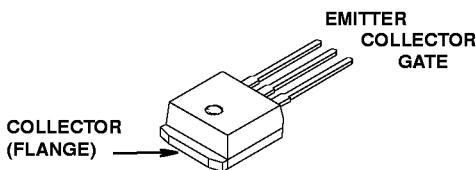
JEDEC STYLE TO-247



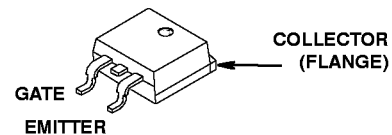
JEDEC TO-220AB (ALTERNATE VERSION)



JEDEC TO-262AA



JEDEC TO-263AB



### HARRIS SEMICONDUCTOR IGBT PRODUCT IS COVERED BY ONE OR MORE OF THE FOLLOWING U.S. PATENTS

4,364,073	4,417,385	4,430,792	4,443,931	4,466,176	4,516,143	4,532,534	4,567,641
4,587,713	4,598,461	4,605,948	4,618,872	4,620,211	4,631,564	4,639,754	4,639,762
4,641,162	4,644,637	4,682,195	4,684,413	4,694,313	4,717,679	4,743,952	4,783,690
4,794,432	4,801,986	4,803,533	4,809,045	4,809,047	4,810,665	4,823,176	4,837,606
4,860,080	4,883,767	4,888,627	4,890,143	4,901,127	4,904,609	4,933,740	4,963,951
4,969,027							

# HGTG15N120C3, HGTP15N120C3, HGT1S15N120C3, HGT1S15N120C3S

## Absolute Maximum Ratings $T_C = 25^\circ\text{C}$ , Unless Otherwise Specified

	HGTG15N120C3, HGTP15N120C3, HGT1S15N120C3S, HGT1S15N120C3S	UNITS
Collector to Emitter Voltage	1200	V
Collector Current Continuous		
At $T_C = 25^\circ\text{C}$	35	A
At $T_C = 110^\circ\text{C}$	15	A
Collector Current Pulsed (Note 1)	120	A
Gate to Emitter Voltage Continuous	$\pm 20$	V
Gate to Emitter Voltage Pulsed	$\pm 30$	V
Switching Safe Operating Area at $T_J = 150^\circ\text{C}$ , Figure 14	15A at 1200V	
Power Dissipation Total at $T_C = 25^\circ\text{C}$	164	W
Power Dissipation Derating $T_C > 25^\circ\text{C}$	1.32	W/ $^\circ\text{C}$
Reverse Voltage Avalanche Energy	100	mJ
Operating and Storage Junction Temperature Range	-55 to 150	$^\circ\text{C}$
Maximum Lead Temperature for Soldering	260	$^\circ\text{C}$
Short Circuit Withstand Time (Note 2) at $V_{GE} = 15\text{V}$	6	$\mu\text{s}$
Short Circuit Withstand Time (Note 2) at $V_{GE} = 10\text{V}$	25	$\mu\text{s}$

CAUTION: Stresses above those listed in "Absolute Maximum Ratings" may cause permanent damage to the device. This is a stress only rating and operation of the device at these or any other conditions above those indicated in the operational sections of this specification is not implied.

### NOTES:

- Pulse width limited by maximum junction temperature.
- $V_{CE(PK)} = 720\text{V}$ ,  $T_J = 125^\circ\text{C}$ ,  $R_{GE} = 25\Omega$ .

## Electrical Specifications $T_C = 25^\circ\text{C}$ , Unless Otherwise Specified

PARAMETER	SYMBOL	TEST CONDITIONS	MIN	TYP	MAX	UNITS	
Collector to Emitter Breakdown Voltage	$BV_{CES}$	$I_C = 250\mu\text{A}$ , $V_{GE} = 0\text{V}$	1200	-	-	V	
Emitter to Collector Breakdown Voltage	$BV_{ECS}$	$I_C = 10\text{mA}$ , $V_{GE} = 0\text{V}$	15	25	-	V	
Collector to Emitter Leakage Current	$I_{CES}$	$V_{CE} = BV_{CES}$	$T_C = 25^\circ\text{C}$	-	-	250	$\mu\text{A}$
			$T_C = 150^\circ\text{C}$	-	-	3.0	mA
Collector to Emitter Saturation Voltage	$V_{CE(SAT)}$	$I_C = I_{C110}$ , $V_{GE} = 15\text{V}$	$T_C = 25^\circ\text{C}$	-	2.3	3.5	V
			$T_C = 150^\circ\text{C}$	-	2.4	3.2	V
Gate to Emitter Threshold Voltage	$V_{GE(TH)}$	$I_C = 250\mu\text{A}$ , $V_{CE} = V_{GE}$	4.0	5.6	7.5	V	
Gate to Emitter Leakage Current	$I_{GES}$	$V_{GE} = \pm 20\text{V}$	-	-	$\pm 100$	nA	
Switching SOA	SSOA	$T_J = 150^\circ\text{C}$ , $R_G = 10\Omega$ , $V_{GE} = 15\text{V}$ , $L = 1\text{mH}$	$V_{CE(PK)} = 960\text{V}$	40	-	-	A
			$V_{CE(PK)} = 1200\text{V}$	15	-	-	A
Gate to Emitter Plateau Voltage	$V_{GEP}$	$I_C = I_{C110}$ , $V_{CE} = 0.5 BV_{CES}$	-	8.8	-	V	
On-State Gate Charge	$Q_{g(ON)}$	$I_C = I_{C110}$ , $V_{CE} = 0.5 BV_{ES}$	$V_{GE} = 15\text{V}$	-	75	100	nC
			$V_{GE} = 20\text{V}$	-	100	130	nC
Current Turn-On Delay Time	$t_{d(ON)I}$	$T_J = 150^\circ\text{C}$	-	17	-	ns	
Current Rise Time	$t_{rI}$	$I_{CE} = I_{C110}$ , $V_{CE(PK)} = 0.8 BV_{CES}$ , $V_{GE} = 15\text{V}$ , $R_G = 10\Omega$ , $L = 1\text{mH}$	-	25	-	ns	
Current Turn-Off Delay Time	$t_{d(OFF)I}$		-	470	550	ns	
Current Fall Time	$t_{fI}$		-	350	400	ns	
Turn-On Energy	$E_{ON}$		-	2100	-	$\mu\text{J}$	
Turn-Off Energy (Note 3)	$E_{OFF}$	-	4700	-	$\mu\text{J}$		
Thermal Resistance	$R_{\theta JC}$		-	-	0.76	$^\circ\text{C}/\text{W}$	

### NOTE:

- Turn-Off Energy Loss ( $E_{OFF}$ ) is defined as the integral of the instantaneous power loss starting at the trailing edge of the input pulse and ending at the point where the collector current equals zero ( $I_{CE} = 0\text{A}$ ). All devices were tested per JEDEC standard No. 24-1 Method for Measurement of Power Device Turn-Off Switching Loss. This test method produces the true total Turn-Off Energy Loss. Turn-On losses include losses due to diode recovery.

Typical Performance Curves

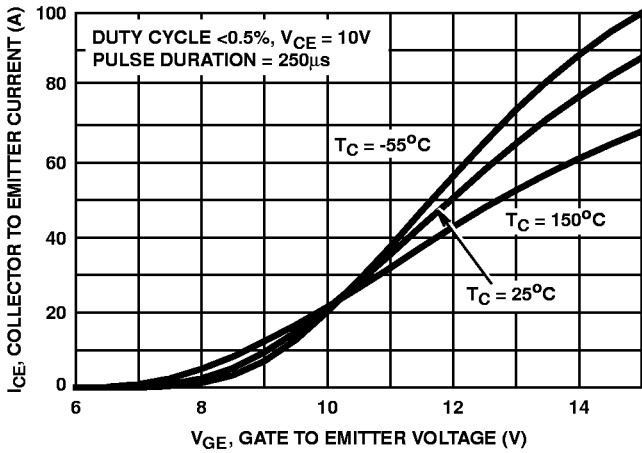


FIGURE 1. TRANSFER CHARACTERISTICS

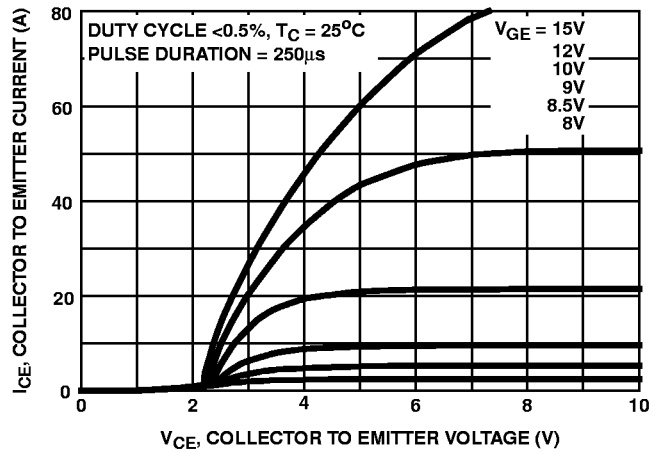


FIGURE 2. SATURATION CHARACTERISTICS

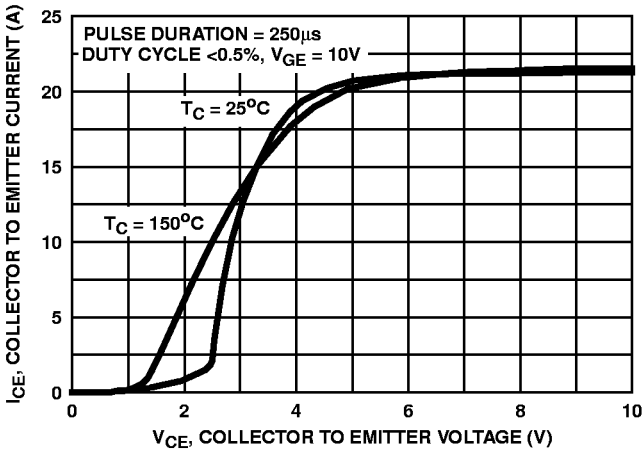


FIGURE 3. COLLECTOR TO EMITTER ON-STATE VOLTAGE

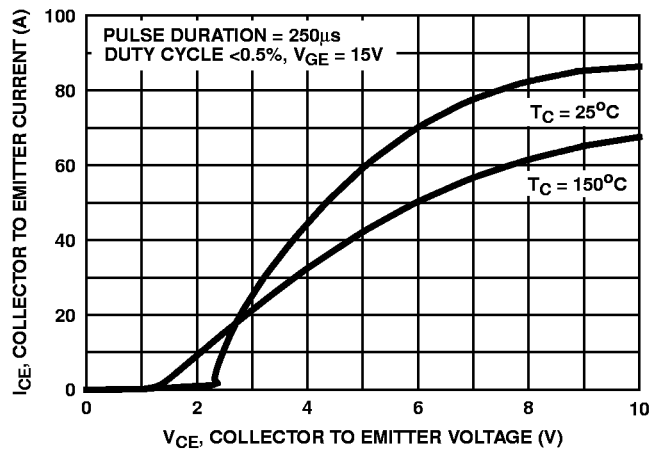


FIGURE 4. COLLECTOR TO EMITTER ON-STATE VOLTAGE

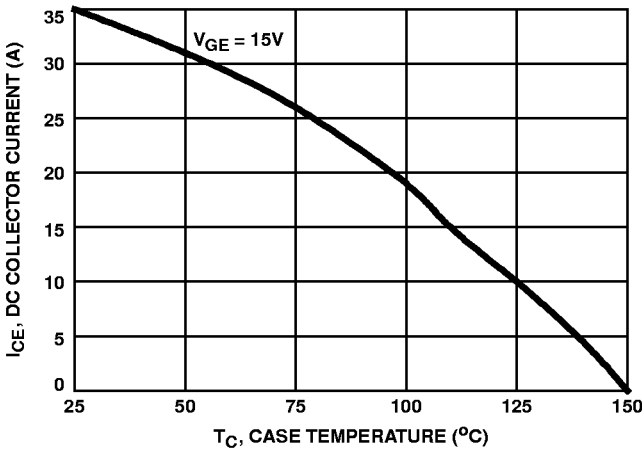


FIGURE 5. DC COLLECTOR CURRENT AS A FUNCTION OF CASE TEMPERATURE

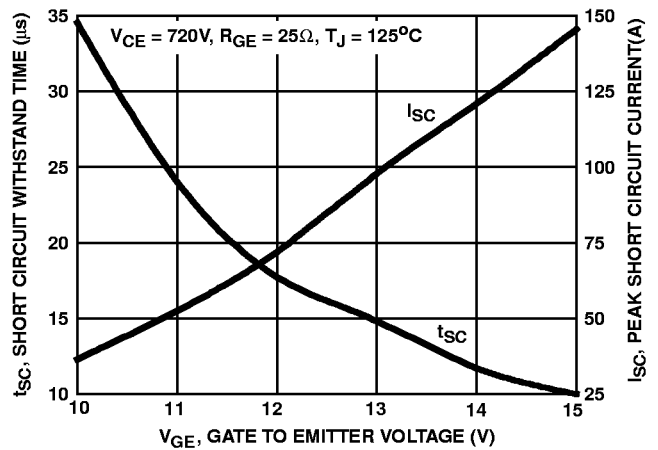


FIGURE 6. SHORT CIRCUIT WITHSTAND TIME

Typical Performance Curves (Continued)

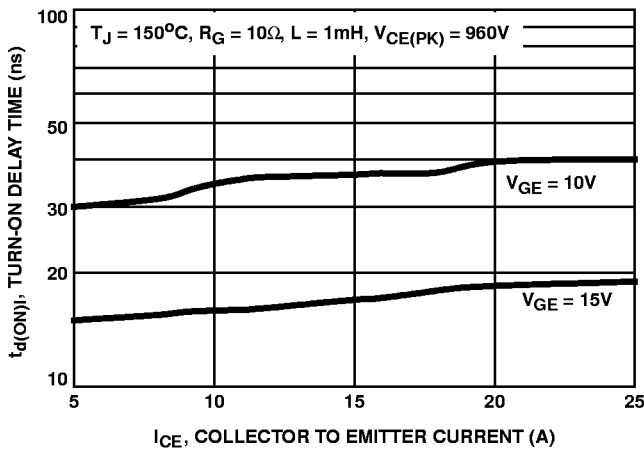


FIGURE 7. TURN-ON DELAY TIME AS A FUNCTION OF COLLECTOR TO EMITTER CURRENT

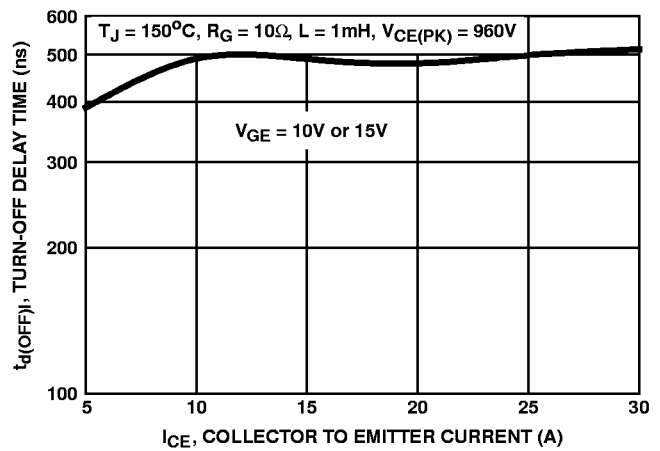


FIGURE 8. TURN-OFF DELAY TIME AS A FUNCTION OF COLLECTOR TO EMITTER CURRENT

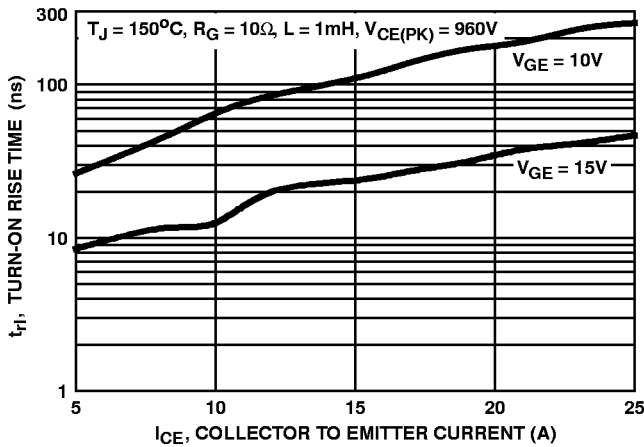


FIGURE 9. TURN-ON RISE TIME AS A FUNCTION OF COLLECTOR TO EMITTER CURRENT

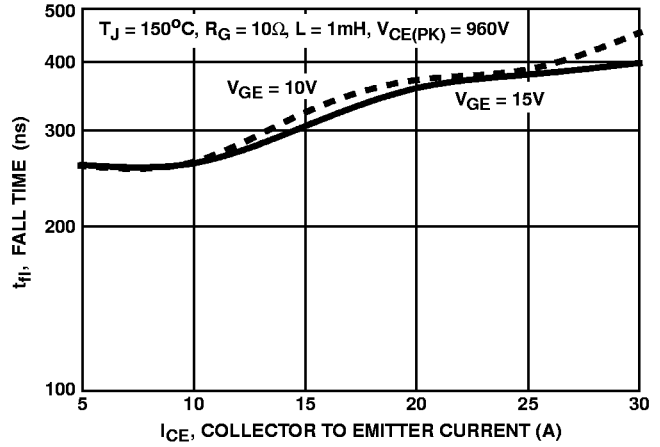


FIGURE 10. TURN-OFF FALL TIME AS A FUNCTION OF COLLECTOR TO EMITTER CURRENT

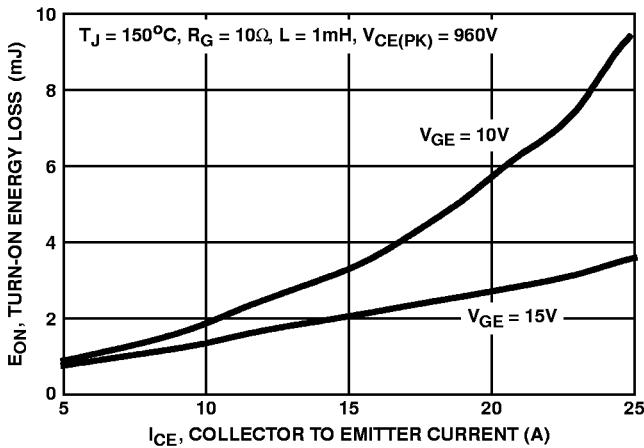


FIGURE 11. TURN-ON ENERGY LOSS AS A FUNCTION OF COLLECTOR TO EMITTER CURRENT

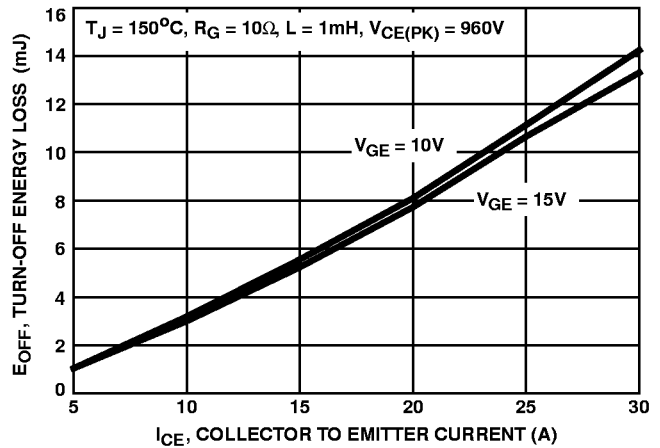


FIGURE 12. TURN-OFF ENERGY LOSS AS A FUNCTION OF COLLECTOR TO EMITTER CURRENT

Typical Performance Curves (Continued)

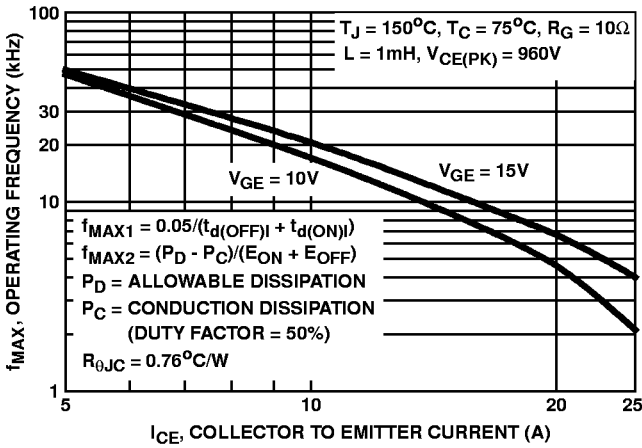


FIGURE 13. OPERATING FREQUENCY AS A FUNCTION OF COLLECTOR TO EMITTER CURRENT

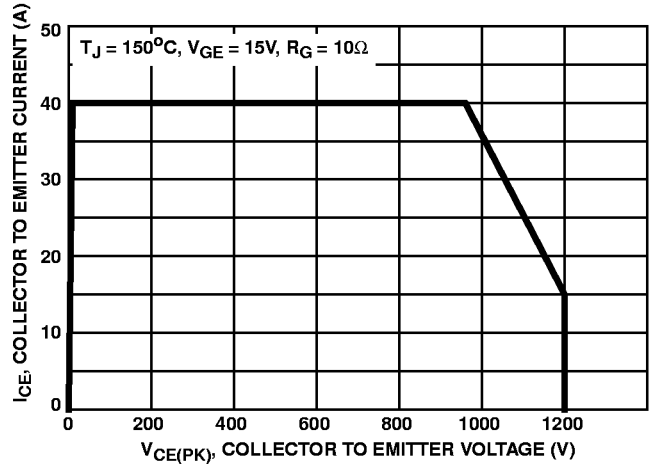


FIGURE 14. SWITCHING SAFE OPERATING AREA

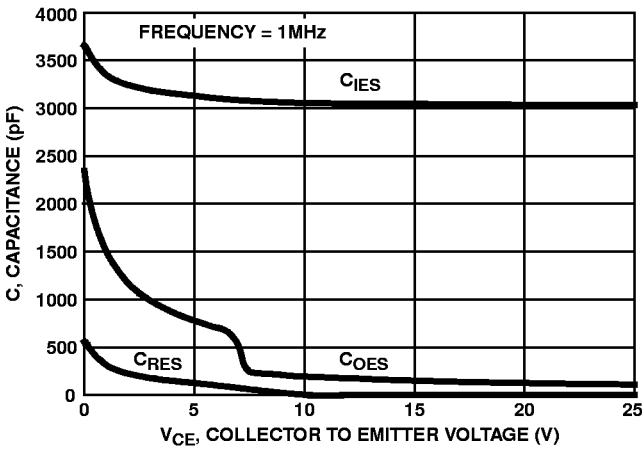


FIGURE 15. CAPACITANCE AS A FUNCTION OF COLLECTOR TO EMITTER VOLTAGE

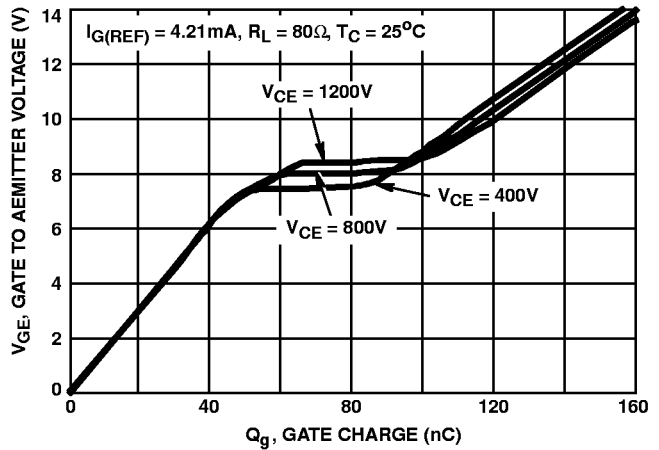


FIGURE 16. GATE CHARGE WAVEFORMS

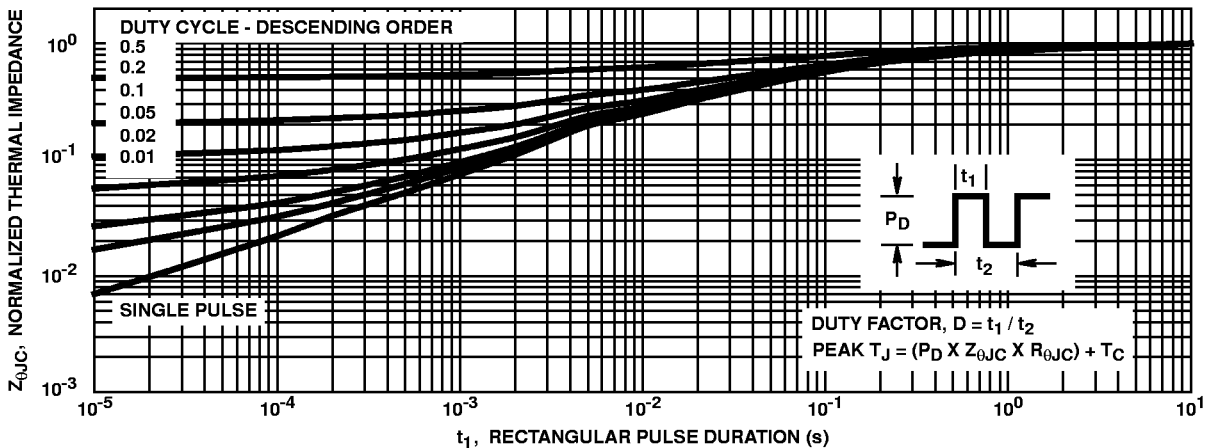


FIGURE 17. IGBT NORMALIZED TRANSIENT THERMAL IMPEDANCE, JUNCTION TO CASE

### Test Circuit and Waveforms

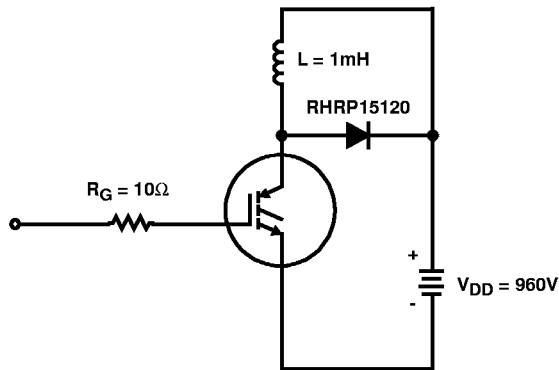


FIGURE 18. INDUCTIVE SWITCHING TEST CIRCUIT

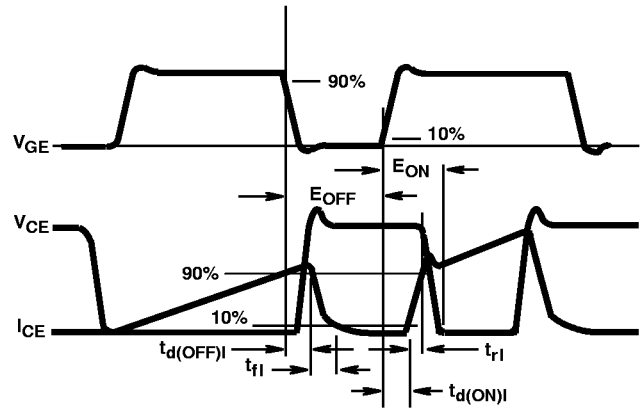


FIGURE 19. SWITCHING TEST WAVEFORMS

### Handling Precautions for IGBT's

Insulated Gate Bipolar Transistors are susceptible to gate-insulation damage by the electrostatic discharge of energy through the devices. When handling these devices, care should be exercised to assure that the static charge built in the handler's body capacitance is not discharged through the device. With proper handling and application procedures, however, IGBTs are currently being extensively used in production by numerous equipment manufacturers in military, industrial and consumer applications, with virtually no damage problems due to electrostatic discharge. IGBTs can be handled safely if the following basic precautions are taken:

1. Prior to assembly into a circuit, all leads should be kept shorted together either by the use of metal shorting springs or by the insertion into conductive material such as "ECCOSORBD LD26™" or equivalent.
2. When devices are removed by hand from their carriers, the hand being used should be grounded by any suitable means - for example, with a metallic wristband.
3. Tips of soldering irons should be grounded.
4. Devices should never be inserted into or removed from circuits with power on.
5. **Gate Voltage Rating** - Never exceed the gate-voltage rating of  $V_{GEM}$ . Exceeding the rated  $V_{GE}$  can result in permanent damage to the oxide layer in the gate region.
6. **Gate Termination** - The gates of these devices are essentially capacitors. Circuits that leave the gate open-circuited or floating should be avoided. These conditions can result in turn-on of the device due to voltage buildup on the input capacitor due to leakage currents or pickup.
7. **Gate Protection** - These devices do not have an internal monolithic zener diode from gate to emitter. If gate protection is required an external zener is recommended.

### Operating Frequency Information

Operating frequency information for a typical device (Figure 13) is presented as a guide for estimating device performance for a specific application. Other typical frequency vs collector current ( $I_{CE}$ ) plots are possible using the information shown for a typical unit in Figures 4, 7, 8, 11 and 12. The operating frequency plot (Figure 13) of a typical device shows  $f_{MAX1}$  or  $f_{MAX2}$  whichever is smaller at each point. The information is based on measurements of a typical device and is bounded by the maximum rated junction temperature.

$f_{MAX1}$  is defined by  $f_{MAX1} = 0.05 / (t_{d(OFF)} + t_{d(ON)})$ . Dead-time (the denominator) has been arbitrarily held to 10% of the on-state time for a 50% duty factor. Other definitions are possible.  $t_{d(OFF)}$  and  $t_{d(ON)}$  are defined in Figure 19. Device turn-off delay can establish an additional frequency limiting condition for an application other than  $T_{JMAX}$ .  $t_{d(OFF)}$  is important when controlling output ripple under a lightly loaded condition.

$f_{MAX2}$  is defined by  $f_{MAX2} = (P_D - P_C) / (E_{OFF} + E_{ON})$ . The allowable dissipation ( $P_D$ ) is defined by  $P_D = (T_{JMAX} - T_C) / R_{\theta JC}$ . The sum of device switching and conduction losses must not exceed  $P_D$ . A 50% duty factor was used (Figure 13) and the conduction losses ( $P_C$ ) are approximated by  $P_C = (V_{CE} \times I_{CE}) / 2$ .

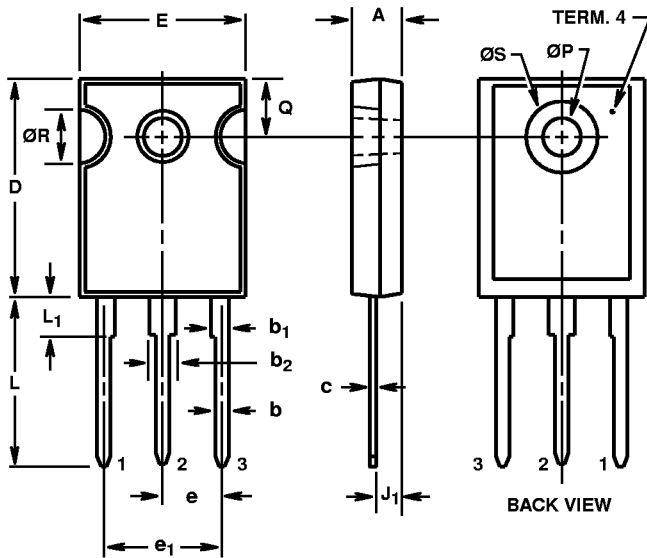
$E_{ON}$  and  $E_{OFF}$  are defined in the switching waveforms shown in Figure 19.  $E_{ON}$  is the integral of the instantaneous power loss ( $I_{CE} \times V_{CE}$ ) during turn-on and  $E_{OFF}$  is the integral of the instantaneous power loss ( $I_{CE} \times V_{CE}$ ) during turn-off. All tail losses are included in the calculation for  $E_{OFF}$ ; i.e. the collector current equals zero ( $I_{CE} = 0$ ).

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HGTG15N120C3, HGTP15N120C3, HGT1S15N120C3, HGT1S15N120C3S

**TO-247**

**3 LEAD JEDEC STYLE TO-247 PLASTIC PACKAGE**



- LEAD NO. 1 - GATE
- LEAD NO. 2 - COLLECTOR
- LEAD NO. 3 - EMITTER
- TERM. 4 - COLLECTOR
- MOUNTING FLANGE

SYMBOL	INCHES		MILLIMETERS		NOTES
	MIN	MAX	MIN	MAX	
A	0.180	0.190	4.58	4.82	-
b	0.046	0.051	1.17	1.29	2, 3
b <sub>1</sub>	0.060	0.070	1.53	1.77	1, 2
b <sub>2</sub>	0.095	0.105	2.42	2.66	1, 2
c	0.020	0.026	0.51	0.66	1, 2, 3
D	0.800	0.820	20.32	20.82	-
E	0.605	0.625	15.37	15.87	-
e	0.219 TYP		5.56 TYP		4
e <sub>1</sub>	0.438 BSC		11.12 BSC		4
J <sub>1</sub>	0.090	0.105	2.29	2.66	5
L	0.620	0.640	15.75	16.25	-
L <sub>1</sub>	0.145	0.155	3.69	3.93	1
ØP	0.138	0.144	3.51	3.65	-
Q	0.210	0.220	5.34	5.58	-
ØR	0.195	0.205	4.96	5.20	-
ØS	0.260	0.270	6.61	6.85	-

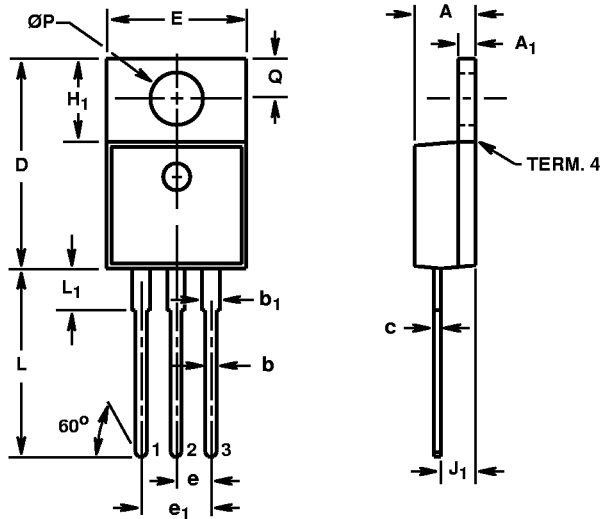
NOTES:

1. Lead dimension and finish uncontrolled in L<sub>1</sub>.
2. Lead dimension (without solder).
3. Add typically 0.002 inches (0.05mm) for solder coating.
4. Position of lead to be measured 0.250 inches (6.35mm) from bottom of dimension D.
5. Position of lead to be measured 0.100 inches (2.54mm) from bottom of dimension D.
6. Controlling dimension: Inch.
7. Revision 1 dated 1-93.

HGTG15N120C3, HGTP15N120C3, HGT1S15N120C3, HGT1S15N120C3S

**TO-220AB (Alternate Version)**

3 LEAD JEDEC TO-220AB PLASTIC PACKAGE



- LEAD NO. 1 - GATE
- LEAD NO. 2 - COLLECTOR
- LEAD NO. 3 - EMITTER
- TERM. 4 - COLLECTOR

SYMBOL	INCHES		MILLIMETERS		NOTES
	MIN	MAX	MIN	MAX	
A	0.170	0.180	4.32	4.57	-
A <sub>1</sub>	0.048	0.052	1.22	1.32	2, 4
b	0.030	0.034	0.77	0.86	2, 4
b <sub>1</sub>	0.045	0.055	1.15	1.39	2, 4
c	0.018	0.022	0.46	0.55	2, 4
D	0.590	0.610	14.99	15.49	-
E	0.395	0.405	10.04	10.28	-
e	0.100 TYP		2.54 TYP		5
e <sub>1</sub>	0.200 BSC		5.08 BSC		5
H <sub>1</sub>	0.235	0.255	5.97	6.47	-
J <sub>1</sub>	0.095	0.105	2.42	2.66	6
L	0.530	0.550	13.47	13.97	-
L <sub>1</sub>	0.110	0.130	2.80	3.30	3
$\varnothing P$	0.149	0.153	3.79	3.88	-
Q	0.105	0.115	2.66	2.92	-

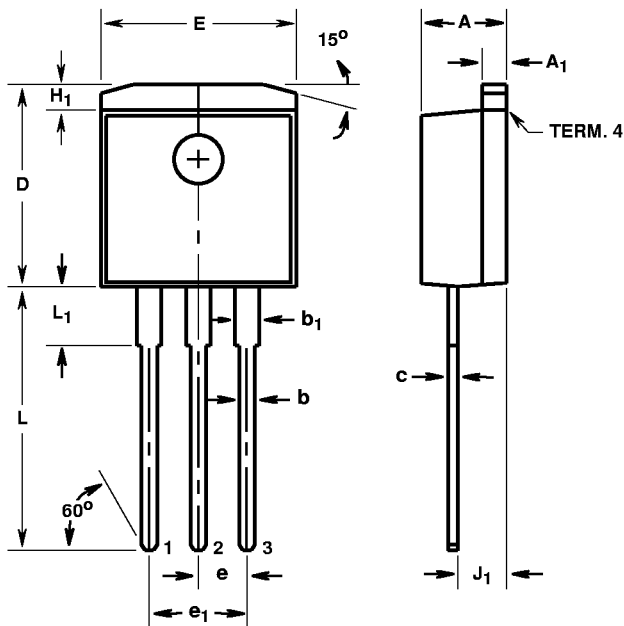
NOTES:

1. These dimensions are within allowable dimensions of Rev. J of JEDEC TO-220AB outline dated 3-24-87.
2. Dimension (without solder).
3. Solder finish uncontrolled in this area.
4. Add typically 0.002 inches (0.05mm) for solder plating.
5. Position of lead to be measured 0.250 inches (6.35mm) from bottom of dimension D.
6. Position of lead to be measured 0.100 inches (2.54mm) from bottom of dimension D.
7. Controlling dimension: Inch.
8. Revision 2 dated 10-95.

HGTG15N120C3, HGTP15N120C3, HGT1S15N120C3, HGT1S15N120C3S

**TO-262AA**

3 LEAD JEDEC TO-262AA PLASTIC PACKAGE



- LEAD NO. 1 - GATE
- LEAD NO. 2 - COLLECTOR
- LEAD NO. 3 - EMITTER
- TERM. 4 - COLLECTOR

SYMBOL	INCHES		MILLIMETERS		NOTES
	MIN	MAX	MIN	MAX	
A	0.170	0.180	4.32	4.57	-
A <sub>1</sub>	0.048	0.052	1.22	1.32	3, 4
b	0.030	0.034	0.77	0.86	3, 4
b <sub>1</sub>	0.045	0.055	1.15	1.39	3, 4
c	0.018	0.022	0.46	0.55	3, 4
D	0.405	0.425	10.29	10.79	-
E	0.395	0.405	10.04	10.28	-
e	0.100 TYP		2.54 TYP		5
e <sub>1</sub>	0.200 BSC		5.08 BSC		5
H <sub>1</sub>	0.045	0.055	1.15	1.39	-
J <sub>1</sub>	0.095	0.105	2.42	2.66	6
L	0.530	0.550	13.47	13.97	-
L <sub>1</sub>	0.110	0.130	2.80	3.30	2

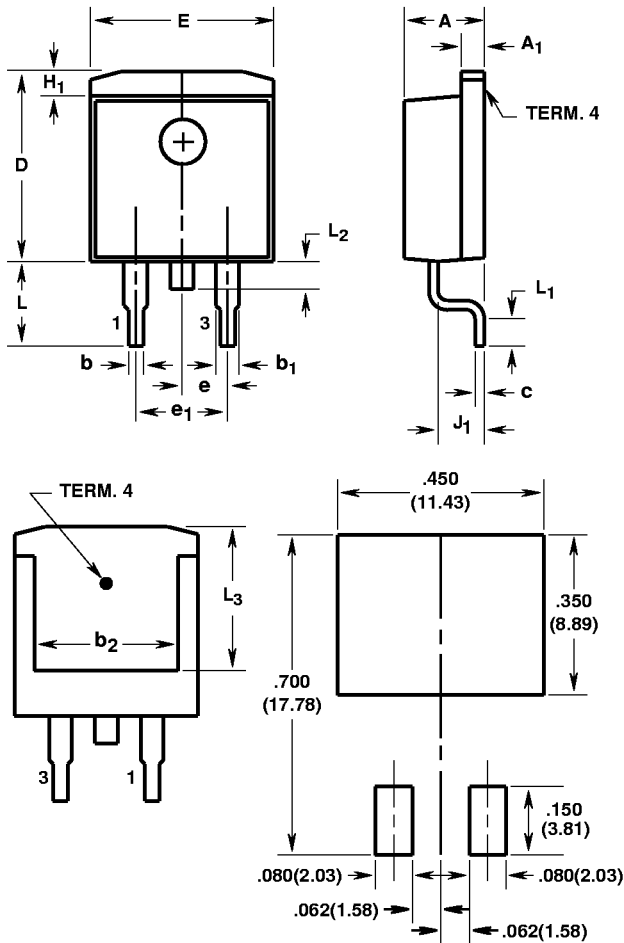
NOTES:

1. These dimensions are within allowable dimensions of Rev. A of JEDEC TO-262AA outline dated 6-90.
2. Solder finish uncontrolled in this area.
3. Dimension (without solder).
4. Add typically 0.002 inches (0.05mm) for solder plating.
5. Position of lead to be measured 0.250 inches (6.35mm) from bottom of dimension D.
6. Position of lead to be measured 0.100 inches (2.54mm) from bottom of dimension D.
7. Controlling dimension: Inch.
8. Revision 4 dated 10-95.

HGTG15N120C3, HGTP15N120C3, HGT1S15N120C3, HGT1S15N120C3S

**TO-263AB**

SURFACE MOUNT JEDEC TO-263AB PLASTIC PACKAGE



MINIMUM PAD SIZE RECOMMENDED FOR SURFACE-MOUNTED APPLICATIONS

- LEAD NO. 1 - GATE
- LEAD NO. 3 - EMITTER
- TERM. 4 - COLLECTOR

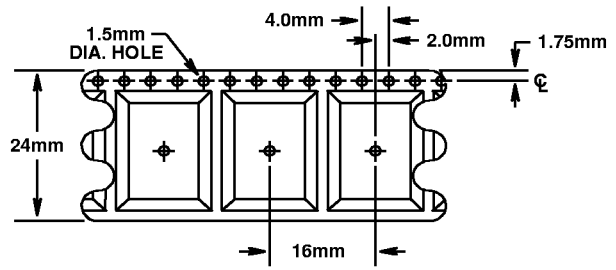
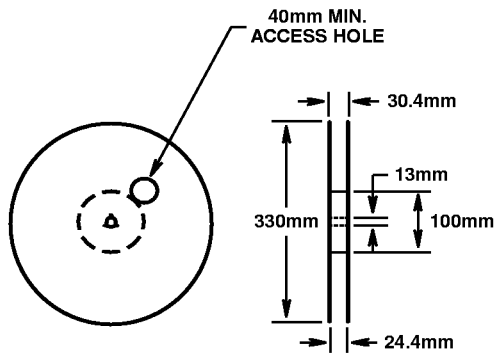
SYMBOL	INCHES		MILLIMETERS		NOTES
	MIN	MAX	MIN	MAX	
A	0.170	0.180	4.32	4.57	-
A <sub>1</sub>	0.048	0.052	1.22	1.32	4, 5
b	0.030	0.034	0.77	0.86	4, 5
b <sub>1</sub>	0.045	0.055	1.15	1.39	4, 5
b <sub>2</sub>	0.310	-	7.88	-	2
c	0.018	0.022	0.46	0.55	4, 5
D	0.405	0.425	10.29	10.79	-
E	0.395	0.405	10.04	10.28	-
e	0.100 TYP		2.54 TYP		7
e <sub>1</sub>	0.200 BSC		5.08 BSC		7
H <sub>1</sub>	0.045	0.055	1.15	1.39	-
J <sub>1</sub>	0.095	0.105	2.42	2.66	-
L	0.175	0.195	4.45	4.95	-
L <sub>1</sub>	0.090	0.110	2.29	2.79	4, 6
L <sub>2</sub>	0.050	0.070	1.27	1.77	3
L <sub>3</sub>	0.315	-	8.01	-	2

NOTES:

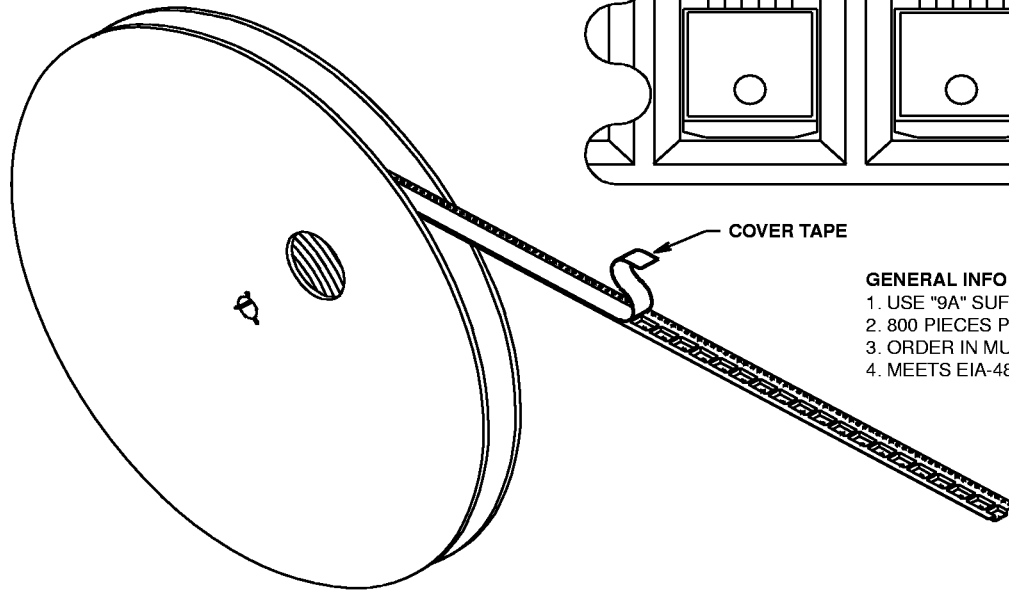
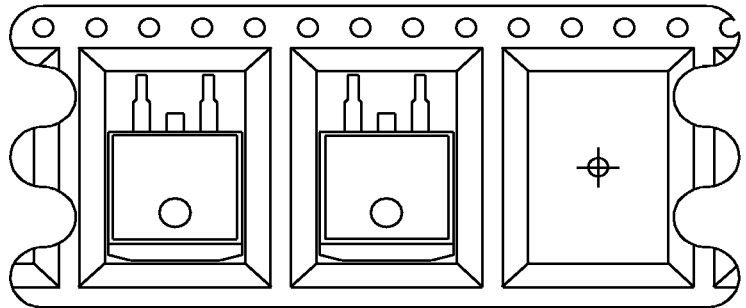
1. These dimensions are within allowable dimensions of Rev. C of JEDEC TO-263AB outline dated 2-92.
2. L<sub>3</sub> and b<sub>2</sub> dimensions established a minimum mounting surface for terminal 4.
3. Solder finish uncontrolled in this area.
4. Dimension (without solder).
5. Add typically 0.002 inches (0.05mm) for solder plating.
6. L<sub>1</sub> is the terminal length for soldering.
7. Position of lead to be measured 0.120 inches (3.05mm) from bottom of dimension D.
8. Controlling dimension: Inch.
9. Revision 7 dated 10-95.

**TO-263AB**

24mm TAPE AND REEL



USER DIRECTION OF FEED



COVER TAPE

**GENERAL INFORMATION**

1. USE "9A" SUFFIX ON PART NUMBER.
2. 800 PIECES PER REEL.
3. ORDER IN MULTIPLES OF FULL REELS ONLY.
4. MEETS EIA-481 REVISION "A" SPECIFICATIONS.

Revision 7 dated 10-95